Notice of References Cited

1 , 5 5

Application/Control No.	Applicant(s)/F	Patent Under
09/828,041	Reexamination HARGIS ET	
Examiner	Art Unit	
Hong C Kim	2186	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0147898	10-2002	Rentschler et al.	711/170
	В	US-2002/0147896	10-2002	Rentschler et al.	711/167
	O	US-2002/0147892	10-2002	Rentschler et al.	711/154
	D	US-2002/0140475	10-2002	Zumkehr et al.	327/170
	Е	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
	F	US-2001/0022824	09-2001	Araki, Satoru	375/360
	G	US-6,532,525	03-2003	Aleksic et al.	711/168
	Н	US-6,496,889	12-2002	Perino et al.	710/110
	-	US-6,459,651	10-2002	Lee et al.	365/233
	٦	US-6,370,630	04-2002	Mizuyabu et al.	711/167
	К	US-6,330,627	12-2001	Toda, Haruki	710/104
	L	US-6,230,245	05-2001	Manning, Troy A.	711/167
	М	US-5,899,570	05-1999	Darmawaskita et al.	374/170

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0			., -		
	Ъ					
	α					
	R					
	S					·
	Т					

NON-PATENT DOCUMENTS

	THOM I A PLAT BOOK METERS							
*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U	Texas Instruments, CD4018B Counter, Data Sheet, 1998						
	v	Texas Instruments, SN5490 Counter, Data Sheet, 1988						
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

14

Notice of References Cited

Application/Control No. 09/828,041	Reexaminati	Applicant(s)/Patent Under Reexamination HARGIS ET AL.		
Examiner	Art Unit			
Hong C Kim	2186	Page 2 of 2		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,710,800	01-1998	Ito, Masahiro	375/370
	В	US-4,970,418	11-1990	Masterson, Anthony D.	327/141
	C	US-4,759,043	07-1988	Lewis, Edward T.	377/116
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	П	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					-

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	>						
	W						
	X						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

Notice of References Cited

Part of Paper No. 4

Application/Control No. Notice of References Cited Application/Control No. 09/827,766 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
1	Α	US-6,532,525	03-2003	Aleksic et al.	711/168
	В	US-6,530,001	03-2003	Lee, Jung-Keun	711/154
Ш	С	US-2002/0172079	11-2002	Hargis et al.	365/193
$\coprod \!$	D	US-2002/0147896	10-2002	Rentschler et al.	711/167
	Е	US-2002/0147892	10-2002	Rentschler et al.	711/154
	F	US-6,414,868	07-2002	Wong et al.	365/51
	G	US-6,370,630	04-2002	Mizuyabu et al.	711/167
Ш	н	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
	1	US-6,125,078	09-2000	Ooishi et al.	365/233
Ш	J	US-6,065,132	05-2000	Takano, Toshiya	713/600
Ш	ķ	US-5,809,340	09-1998	Bertone et al.	710/58
1	L	US-5,727,005	03-1998	Le et al.	714/814
1/4	М	US-5,522,064	05-1996	Aldereguia et al.	713/501

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S			-	,	
	Т					

NON-PATENT DOCUMENTS

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U		
	٧		
	w		
	x		

Applicant(s)/Patent Under Reexamination Application/Control No. 09/827,768 RENTSCHLER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 2 Hong C Kim 2186

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0172079	11-2002	Hargis et al.	365/193
*	В	US-2002/0147898	10-2002	Rentschler et al.	711/170
*	O	US-2002/0147896	10-2002	Rentschler et al.	711/167
*	D	US-2001/0054135	12-2001	Matsuda, Yoichi	711/167
*	Е	US-2001/0003837	06-2001	Norman et al.	711/5
*	F	US-6,553,450	04-2003	Dodd et al.	711/105
*	G	US-6,532,525	03-2003	Aleksic et al.	711/168
*	H	US-6,530,001	03-2003	Lee, Jung-Keun	711/154
*	ı	US-6,424,198	07-2002	Wolford, Barry Joe	327/291
*	J	US-6,370,630	04-2002	Mizuyabu et al.	711/167
*	К	US-6,324,119	11-2001	Kim, Chi-wook	365/233
*	L	US-6,144,598	11-2000	Cooper et al.	365/201
*	М	US-6,065,132	05-2000	Takano, Toshiya	713/600

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		i i			
	Q					
	R	7.77				
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	W	
	x	

Notice of References Cited Application/Control No. 09/828,604 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0172079	11-2002	Hargis et al.	365/193
*	В	US-2002/0147898	10-2002	Rentschler et al.	711/170
*	С	US-2002/0147896	10-2002	Rentschler et al.	711/167
*	D	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
*	ш	US-6,532,525	03-2003	Aleksic et al.	711/168
*	F	US-6,530,001	03-2003	Lee, Jung-Keun	711/154
*	G	US-6,480,946	11-2002	Tomishima et al.	711/167
*	Ŧ	US-6,370,630	04-2002	Mizuyabu et al.	711/167
*	_	US-6,338,113	01-2002	Kubo et al.	711/105
*	J	US-6,125,078	09-2000	Ooishi et al.	365/233
*	К	US-6,065,132	05-2000	Takano, Toshiya	713/600
*	٦	US-5,974,499	10-1999	Norman et al.	711/103
*	М	US-5,809,340	09-1998	Bertone et al.	710/58

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					`
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	8	
	x	

Notice of References Cited Application/Control No. 09/828,604 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 2 of 2 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,727,005	03-1998	Le et al.	714/814
*	В	US-5,522,064	05-1996	Aldereguia et al.	713/501
	С	US-			
	D	US-			
	E	US-			
	F	US-		·	
	G	US-			
1	Н	US-			
	ı	US-		·	
	J	US-	* ***		
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

						C
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				· · · · · · · · · · · · · · · · · · ·	
	R		•			
·	s				-	
	Т					

NON-PATENT DOCUMENTS

		NON TATENT BOOMENTO
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

Notice of References Cited Application/Control No. 09/827,768 Examiner Hong C Kim Applicant(s)/Patent Under Reexamination RENTSCHLER ET AL. Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,727,005	03-1998	Le et al.	714/814
*	В	US-5,701,438	12-1997	Bains, Kuljit S.	711/211
*	С	US-5,522,064	05-1996	Aldereguia et al.	713/501
	D	US-			
	E	US-			
	F	US-			
	G	US-	!		
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	-				
	Q					
	R					
	s					
	Τ			·		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

ences Cited /